ENGINEERING SPECIFICATION

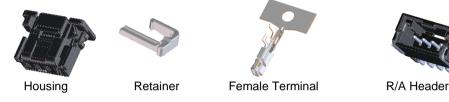
NEW 2.0 W/B CONN REC. HOUSING DuraClik[™] ISL SERIES

1.0 SCOPE

This product specification covers the performance of **2.0mm Pitch DuraClik™ ISL Wire-to-Board Connector System** (includes Housings, Retainers, Female Terminals and SMT Headers - R/A and Straight). Articles which are not included in this specification can be written in the drawings and they are prior to this specification.

2.0 PRODUCT DESCRIPTION

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2.1 PRODUCT DESCRIPTION AND PART NUMBERS

Description	Series numbers	Availability & Remarks
DuraClik™ ISL Female Housing	560123	2,3,4,5,6,7,8,9,10,12 CKT Color options: natural, black, red, blue*
DuraClik™ ISL Retainer	560125	2,3,4,5,6,7,8,9,10,12 CKT Colors options: grey & black*
DuraClik™ ISL Female Terminal	560124-0101	Sn plated for wire AVSS 0.3sq
DuraClik™ R/A Header	502352	2 to 15 CKT, Sn plated, Colors: natural, black, red, blue*
DuraClik™ Straight Header	560020	2 to 15 CKT, Sn plated, Colors: natural, black, red, blue*

* Check sales drawing or contact Molex for detailed information on available colors per version

2.2 DIMENSIONS, MATERIALS, PLATING AND MARKINGS

For each part, all dimensions, materials, plating and marking descriptions can be found on the applicable restricted sales drawing.

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3.0 RATINGS AND APPLICABLE WIRES

Current carrying capability (Wire section 0.3mm²)

Item	Standards							
Rated Voltage (Max.)	125V	AC (rms) / DC						
Rated Current (Max.)	AVSS 0.3 SQ	Insulation Diameter 1.5mm MAX.						
Ambient temperature range		- 40° C to 125° C	:					

*. Remark: Including terminal temperature rise.

4.0 STORAGE CONDITIONS

- Storage temperature: -20~60°C -
- Storage Duration: 6 Months -

5.0 PERFORMANCE

5.1 ELECTRICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Contact Resistance	Mate connectors, measure by dry circuit, 20mV MAX., 10mA. (JIS C5402 5.4)	10 milliohm MAX.
2	Insulation Resistance	Connectors shall be mated and apply 500V DC between adjacent terminals or ground. (JIS C5402 5.2/MIL-STD-202 Method 302)	1000 mega ohm MIN
3	Dielectric Strength	Connectors shall be mated and apply 500V AC (rms) for 1 minute between adjacent terminals or ground.(JIS C5402 5.1/MIL-STD-202 Method 301)	No breakdown
4	Contact Resistance on Crimped Portion	Crimped the applicable wire on to the terminal, measure by dry circuit, 20mV MAX., 10mA.	5 milliohm MAX.
5	Voltage Drop	Measure voltage drop by $12\pm1V$ of open circuit and $1\pm0.05A$ of short circuit at the 75or100mm of point from crimped section. Subtract wire conductor resistance from total resistance.	10mV/A MAX.

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5.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQI	JIREMENT
1	Insertion and Withdrawal Force	Insert and withdraw connectors at the speed rate of 25±3mm/minute.	See p	aragraph 6.
2	Crimping Pull Out Force	Fixed crimped terminal, apply axial pull out force on the wire at the speed rate of 25±3mm/minute. (JIS C5402 6.8)	AVSS 0.3SQ	50N {5.1 kgf} MIN.
3	Terminal Insertion Force	Insert the crimped terminal into the housing.	9.8 N {′	1.0kgf} MAX.
4	Terminal / Housing Retention Force	Apply axial pull out force at the speed rate of 25±3mm/minute on the terminal assembled in the housing.	50 N {	5.1kgf} MIN.
5	Pin Retention Force	Apply axial push force at the speed rate of 25±3mm/minute.	9.8 N {	1.0kgf} MIN.
6	Fitting Nail Peeling Strength	Mount product on PCB only by fitting nails and apply axial pull-up force at the speed rate of 2.5mm/min.	•	10.2kgf} MIN. both nails)
7	Housing / Wafer Retention Force	Mate connectors and apply pull-out force at the speed rate of 25±3mm/min. This test should be done with positive lock locked.	50N {5	5.1kgf} MIN.

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5.3 ENVIRONMENTAL REQUIREMENTS AND OTHERS

ITEM	DESCRIPTION	TEST CONDITION	REQ	UIREMENT	
1	Repeated Insertion/ Withdrawal	When mated up to 30 cycles repeatedly by the rate of 10 cycles/minute.	Contact Resistance	20 milliohm MAX.	
2	Temperature Rise	Carrying rated current load. (UL 498)	Temperature Rise	30 ℃ MAX.	
			Appearance	No Damage	
•		Acceleration : 44m/s ² Sweep time: 20-200-20Hz in 3minutes	Contact Resistance	20 milliohm MAX.	
3	Vibration	Duration : 3hours in each X, Y, Z axes Open circuit voltage: 20mV max. Short circuit current: 10mA max.	Voltage Drop	20 mV/A MAX.	
			Discontinuity	1 microsecond MAX	
		981m/s ² (100G), 3 strokes in each X,	Appearance	No Damage	
4	Mechanical Shock	Y, Z axes. Operation time: 6ms	Discontinuity	1 microsecond MA>	
				No Damage	
5	5 Heat Resistance	(JIS C0021/ MIL-STD-202 method 108)	Contact Resistance	20 milliohm MAX.	
	0.11		Appearance	No Damage	
6	Cold Resistance	-40±3℃,96 hours. (JIS C0020)	Contact Resistance	20 milliohm MAX.	
			Appearance	No Damage	
		Temperature: 60±2℃	Contact Resistance	20 milliohm MAX. Must meet 5.1.3	
7	Humidity	Relative Humidity: 90-95% Duration: 96 hours (JIS C0022/MIL-STD-202 Method 103)	Dielectric Strength		
		6.	Resistance	100 mega ohm MIN	

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5.3 ENVIRONMENTAL REQUIREMENTS AND OTHERS (Continued)

	DESCRIPTION	TEST CO	NDITIO	N	REQUIREMENT				
					Арре	earance	N	o Damage	e
						tion and wal Feeling	No	o scratche	s
		1000 cycle	s of			l / Housing ion Force	Mus	st meet 5.2	2.4
8	Temperature Cycling	a) -30°C: 3 b) +80°C: 3	0 minut		Pu	mping Il Out orce	Mus	st meet 5.2	2.2
						ig / Wafer ion Force	50 N	{5.1kgf} N	MIN.
						ontact istance	20 m	illiohm M	AX.
			4 hours exposure to a salt			ge Drop	20	mV/A MA	Χ.
			•		Арре	earance	N	o Damage	Э
9	Salt Spray	at 35±2 ℃		1% solution		ontact istance	20 milliohm MAX.		AX.
		24 hours e	hours exposure to 50±5 ppm. ₋ ₂ gas at 40±2℃			Appearance		o Damage	e
10	SO₂ gas					ontact istance	20 m	illiohm M	AX.
11	Solder-ability	Soldering ⁻ Solder Ten		±0.5 sec. re: 245±5℃		older etting	90% of immersed area must show no voids, pinholes.		
		Refer solde	oring m	othod	Арре	earance	N	o Damage	е
12	Resistance to	See parag		enioù		ontact istance	20 m	illiohm M	AX.
12	Soldering Heat	Press the s	solder tr	owel of 350±5	Appearance		No Damage		Э
		°C for 3sec			Res	ontact stance	20 m	illiohm M	AX.
	Twisting	Repeat ins the connect		ind removing	Appe	arance	N	o Damage	Э
13	Durability	twisting it u	upward,	downward, to eft by hands.		ontact istance	20 m	iilliohm M	AX.
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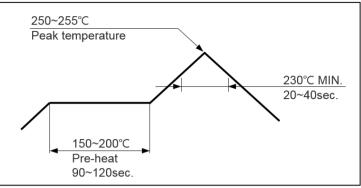
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6.0 INSERTION / WITHDRAWAL FORCE (REFER TO PS-50515-001)

No.of	115.07	Inse	rtion Force (N	IAX.)	Withd	Irawal Ford	ce(MIN.)
СКТ.	UNIT	1st	6th	30th	1st	6th	30th
2	N {kgf}	35.2 {3.6}		1.0 {0.10}			
3	N	43.1	40.1	40.1	1.5	1.5	2.1
	{kgf}	{4.4}	{4.1}	{4.1}	{0.15}	{0.15}	{0.21}
4	N	50.9	47.0	47.0	2.0	2.0	3.2
	{kgf}	{5.2}	{4.8}	{4.8}	{0.20}	{0.20}	{0.33}
5	N	58.8	53.9	53.9	2.8	2.8	3.7
	{kgf}	{6.0}	{5.5}	{5.5}	{0.29}	{0.29}	{0.38}
6	N	64.6	58.8	58.8	3.5	3.5	4.2
	{kgf}	{6.6}	{6.0}	{6.0}	{0.36}	{0.36}	{0.43}
7	N	70.5	63.7	63.7	3.9	3.9	4.6
	{kgf}	{7.2}	{6.5}	{6.5}	{0.40}	{0.40}	{0.47}
8	N	76.4	68.6	68.6	4.2	4.2	5.0
	{kgf}	{7.8}	{7.0}	{7.0}	{0.43}	{0.43}	{0.51}
9	N	82.3	73.5	73.5	4.7	4.7	5.4
	{kgf}	{8.4}	{7.5}	{7.5}	{0.48}	{0.48}	{0.55}
10	N	88.2	78.4	78.4	5.3	5.3	5.8
	{kgf}	{9.0}	{8.0}	{8.0}	{0.54}	{0.54}	{0.59}
11	N	94.0	83.3	83.3	5.8	5.8	6.2
	{kgf}	{9.6}	{8.5}	{8.5}	{0.59}	{0.59}	{0.63}
12	N	99.9	88.2	88.2	6.4	6.4	6.6
	{kgf}	{10.2}	{9.0}	{9.0}	{0.65}	{0.65}	{0.67}
13	N	107.6	94.9	94.9	6.7	6.7	7
	{kgf}	{11.0}	{9.7}	{9.7}	{0.68}	{0.68}	{0.71}
14	N	113.9	100.2	100.2	7.2	7.2	7.4
	{kgf}	{11.6}	{10.2}	{10.2}	{PA73}	{0.73}	{0.75}
15	N {kgf}	120.2 {12.3}	105.6 {10.8}	105.6 P {10.8}	RO.79}	7.7 {0.79}	7.8 {0.80}
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7.0 INFRARED REFLOW CONDITION



Temperature condition graph (Temperature on board pattern side / Product surface)

8.0 INSTRUCTION UPON USAGE

- 1) Positive lock should be released when unmating connectors.
- 2) Connectors should be mated straightly. Angled mating operation has possibility of deforming pins

9.0 NOTES

- 1) Mounting performance doesn't contain the influence of the warp of PCB.
- 2) Repairing with soldering iron should be done in specified condition.
- 3) It is necessary to consult separately when mount product on a special PCB or FPC.
- 4) There is no influence in the product performance though the twist might be generated in the terminal plating part according to the reflow condition.
- 5) There is no influence in the product performance though discoloration might be generated in the resin according to the reflow condition.
- 6) There is no influence in the product performance though black spots are seen on the surface of the resin of this product.
- 7) There is no influence in the product performance though scratches are seen on the surface of the resin of this product.
- 8) Coplanarity is assured only before mounting.
- 9) Changing recommended pattern causes problems.
- 10) Thickness 0.15mm, aperture ratio 100% metal mask is used in thin specification.

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